

В

С

8.50 | 7.74 | 6.09 | 0.40 |

Dimensions

Min.

Max.

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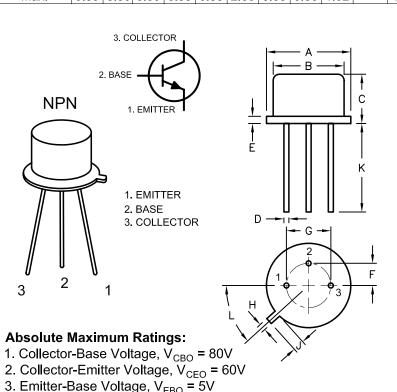
REVISIONS			DOC. N	0. SPC-F005	* Effec	ctive: 7/8/0	2 * DCP	No: 1398
DCP #	REV	DESCRIPTION	DRAWN	DATE	CHECKD	DATE	APPRVD	DATE
1447	Α	RELEASED	HYO	5/15/02	JWM	2/20/04	JC	2/20/04
1885	В	UPDATED TO ROHS COMPLIANCE	ΕO	02/03/06	Ю	2/6/06	но	2/6/06

E	F	G	Н	J	K	L
	2 41	4 82	0.71	0.73	12 70	42°

SPC-F005.DWG

9.39 | 8.50 | 6.60 | 0.53 | 0.88 | 2.66 | 5.33 | 0.86 | 1.02 |





primarily for amplifier and switching applications. This device features high breakdown voltage, low leakage current, low capacity, and beta useful over an extremely wide current range.

This is a silicon NPN transistor in a TO-39 type case designed

Electrical Characteristics: (T_A = +25°C Unless otherwise specified)

DEVICIONO

Parameter	Symbol Test Conditions	Min Max Unit
OFF Characteristics		

$I_{\rm C} = 0.1 \, {\rm mA}, I_{\rm B} = 0$ Collector-Emitter Breakdown Voltage 60 V $I_{\rm C} = 100 \mu A, I_{\rm E} = 0$ $V_{(BR)CBO}$ 80 Collector-Base Breakdown Voltage $I_{E} = 100 \mu A, I_{C} = 0$ Emitter-Base Breakdown Voltage $V_{BE} = 4V, I_{C} = 0$ **Emitter Cut-Off Current** 0.25 μΑ

ON Characteristics, Note 1

DC Current Gain	h _{FE}	V _{CE} = 10V, I _C = 150mA	50	-	250
		$V_{CE} = 2.5V, I_{C} = 150mA$	25	-	-
Collector-Emitter Saturation Voltage	V _{CE(sat)}	I _C = 150mA, I _B = 15mA	-	1.4	V
Base-Emitter Saturation Voltage	V _{BE(sat)}	I _C = 150mA, I _B = 15mA	-	1.0	V

Small-Signal Characteristics

Current Gain-Bandwidth Product	f _T	$V_{CE} = 10V, I_{C} = 50mA, f = 20MHz$	100	-	MHz
Output Capacitance	C _{obo}	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	-	12	рF
Input Capacitance	C _{ibo}	$V_{BE} = 500 \text{mV}, I_{C} = 0, f = 1 \text{MHz}$	-	80	рF

Note 1. Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 1\%$.

Derate above 25°C = 28.6mW/°C 7. Operating Junction Temperature Range, T₁ = -65° to +200°C

Derate above 25°C = 4.6mW/°C

8. Storage Temperature Range, T_{stq} = -65° to +200°C

6. Total Device Dissipation ($T_C = +25^{\circ}C$), $P_D = 5W$

5. Total Device Dissipation ($T_A = +25^{\circ}C$), $P_D = 800 \text{mW}$

ALL STATEMENTS AND TECHNICAL INFORMATION CONTAINED HEREIN ARE BASED UPON INFORMATION AND/OR TESTS WE BELIEVE TO BE ACCURATE AND RELIABLE. SINCE CONDITIONS OF USE ARE BEYOND OUR CONTROL, THE USER SHALL DETERMINE THE SUITABILITY OF THE PRODUCT FOR THE INTENDED USE AND ASSUME ALL RISK AND LIABILITY WHATSOEVER IN CONNECTION THEREWITH.

4. Continuous Collector Current, $I_C = 0.7A$

TOLERANCES:

UNLESS OTHERWISE SPECIFIED. DIMENSIONS ARE FOR REFERENCE PURPOSES ONLY.

DRAWN BY:	DATE:	DRAW	'ING TITL
HISHAM ODISH	5/15/02		Т
CHECKED BY:	DATE:	SIZE	DWG.
JEFF MCVICKER	2/20/04	Α	
APPROVED BY:	DATE:		
JOHN COLE	2/20/04	SCAL	E: NTS

Transistor, Bipolar, Metal, TO-39, NPN ELECTRONIC FILE NO. REV 2N3053A 35C0699.DWG

SHEET:

1 OF 1

U.O.M.: Millimeters